



FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary) March 30, 2004		ATTY DOCKET NO. 00684.003530		APPLICATION NO. 10/670,398			
		APPLICANT TETSUYA OHASHI ET AL.					
		FILING DATE September 26, 2003		GROUP 2853			
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
RD	3,863,261	01/1975	Klein	—	—		
RH	5,550,570	08/1996	Kurata et al.	—	—		
RH	5,835,111	11/1998	Balazer	—	—		
RH	6,151,046	11/2000	Abe et al.	—	—		
FOREIGN PATENT DOCUMENTS							
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT	
RD	JP 7-25112	01/1995	Japan	—	—	Abstract	
RH	JP 10-100401	04/1998	Japan	—	—	Abstract	
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
EXAMINER	REHAB DUN		DATE CONSIDERED	10/12/05			

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Sheet 1 of 1



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FORM PTO 1449 (modified) U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE LIST OF REFERENCES CITED BY APPLICANT(S) (Use several sheets if necessary) December 1, 2003			ATTY DOCKET NO. 00684.003530		APPLICATION NO. 10/670,398		
			APPLICANT TETSUYA OHASHI ET AL.				
			FILING DATE September 26, 2003		GROUP Unassigned		
U.S. PATENT DOCUMENTS							
*EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
<i>Rb</i>	5,515,086	05/1996	Kakizaki et al.				
<i>RP</i>	6,220,697 B1	04/2001	Yamanaka et al.				
FOREIGN PATENT DOCUMENTS							
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION YES/NO/ OR ABSTRACT	
<i>RP</i>	JP 5-50633	03/1993	Japan			Abstract	
	JP 5-229144	09/1993	Japan			Abstract	
	JP 9-150540	06/1997	Japan			Abstract	
	JP 2814330	08/1998	Japan			*	
	JP 2002-200742	07/2002	Japan			Abstract	
OTHER DOCUMENT(S) (Including Author, Title, Date, Pertinent Pages, Etc.)							
*U.S. counterpart Patent No. 5,515,086 submitted herewith							
EXAMINER	<i>Reid D. Nak</i>			DATE CONSIDERED		<i>10/12/05</i>	
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